Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,106	CHANG ET AL.
Examiner	Art Unit
Than Nguyen	2187

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
. <u> </u>			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Jpdate prior art review from previous search	5/30/2006	NTV
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